ON Semiconductor®

# FDMC0310AS

## N-Channel PowerTrench® SyncFET™

**30 V, 21 A, 4.4 mΩ**

### Features

- Max $r_{DS(on)}$ = 4.4 mΩ at $V_{GS}$ = 10 V, $I_D$ = 19 A
- Max $r_{DS(on)}$ = 5.2 mΩ at $V_{GS}$ = 4.5 V, $I_D$ = 17.5 A
- Advanced package and silicon combination for low $r_{DS(on)}$ and high efficiency
- SyncFET™ Schottky Body Diode
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

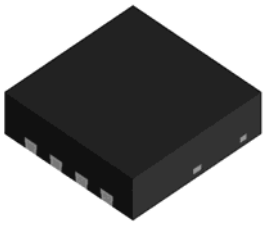
### General Description

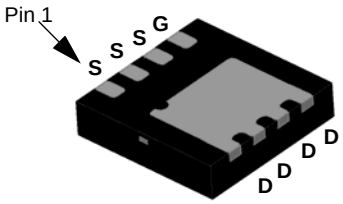
The FDMC0310AS has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance.This device has the added benefit of an efficient monolithic schottky body diode.

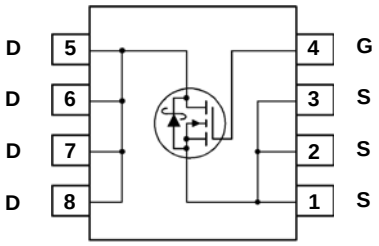
### Applications

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification

**Top** **Bottom**






**MLP 3.3x3.3**

## MOSFET Maximum Ratings $T_A$ = 25 °C unless otherwise noted

| Symbol | Parameter | | | Ratings | Units |
|---|---|---|---|---|---|
| $V_{DS}$ | Drain to Source Voltage | | | 30 | V |
| $V_{DSt}$ | Drain to Source Transient Voltage ( $t_{Transient}$ < 100 ns) | | | 33 | V |
| $V_{GS}$ | Gate to Source Voltage | | (Note 4) | ±20 | V |
| $I_D$ | Drain Current -Continuous | $T_C$ = 25°C | | 21 | A |
| | -Continuous | $T_A$ = 25°C | (Note 1a) | 19 | |
| | -Pulsed | | | 100 | |
| $E_{AS}$ | Single Pulse Avalance Energy | | (Note 3) | 66 | mJ |
| $P_D$ | Power Dissipation | $T_C$ = 25°C | | 36 | W |
| | Power Dissipation | $T_A$ = 25°C | (Note 1a) | 2.4 | |
| $T_J$, $T_{STG}$ | Operating and Storage Junction Temperature Range | | | -55 to +150 | °C |

### Thermal Characteristics

| | | | |
|---|---|---|---|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 3.4 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53 | |

### Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|---|---|---|---|---|---|
| FDMC0310AS | FDMC0310AS | MLP 3.3X3.3 | 13 ” | 12 mm | 3000 units |

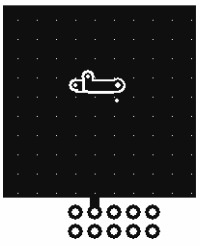
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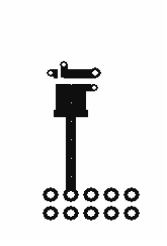
## Electrical Characteristics $T_J$ = 25 °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain to Source Breakdown Voltage | $I_D$ = 1 mA, $V_{GS}$ = 0 V | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = 10 mA, referenced to 25 °C | | 26 | | mV/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = 24 V, $V_{GS}$ = 0 V | | | 500 | μA |
| $I_{GSS}$ | Gate to Source Leakage Current, Forward | $V_{GS}$ = 20 V, $V_{DS}$ = 0 V | | | 100 | nA |
| **On Characteristics** | | | | | | |
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS}$ = $V_{DS}$, $I_D$ = 1 mA | 1.2 | 1.6 | 3.0 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D$ = 10 mA, referenced to 25 °C | | -5 | | mV/°C |
| $r_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS}$ = 10 V, $I_D$ = 19 A | | 3.8 | 4.4 | mΩ |
| | | $V_{GS}$ = 4.5 V, $I_D$ = 17.5 A | | 4.5 | 5.2 | |
| | | $V_{GS}$ = 10 V, $I_D$ = 19 A, $T_J$ = 125 °C | | 4.5 | 5.8 | |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = 5 V, $I_D$ = 19 A | | 106 | | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = 15 V, $V_{GS}$ = 0 V, f = 1 MHz | | 2380 | 3165 | pF |
| $C_{oss}$ | Output Capacitance | | | 885 | 1175 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | | 100 | 150 | pF |
| $R_g$ | Gate Resistance | | 0.1 | 0.7 | 2.5 | Ω |
| **Switching Characteristics** | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD}$ = 15 V, $I_D$ = 19 A, $V_{GS}$ = 10 V, $R_{GEN}$ = 6 Ω | | 11 | 20 | ns |
| $t_r$ | Rise Time | | | 5 | 10 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 30 | 48 | ns |
| $t_f$ | Fall Time | | | 4 | 10 | ns |
| $Q_g$ | Total Gate Charge | $V_{GS}$ = 0 V to 10 V, $V_{DD}$ = 15 V, $I_D$ = 19 A | | 37 | 52 | nC |
| $Q_g$ | Total Gate Charge | $V_{GS}$ = 0 V to 4.5 V, $V_{DD}$ = 15 V, $I_D$ = 19 A | | 18 | 25 | nC |
| $Q_{gs}$ | Gate to Source Charge | | | 6 | | nC |
| $Q_{gd}$ | Gate to Drain “Miller” Charge | | | 6 | | nC |
| **Drain-Source Diode Characteristics** | | | | | | |
| $V_{SD}$ | Source to Drain Diode Forward Voltage | $V_{GS}$ = 0 V, $I_S$ = 2 A (Note 2) | | 0.6 | 0.8 | V |
| | | $V_{GS}$ = 0 V, $I_S$ = 19 A (Note 2) | | 0.8 | 1.2 | |
| $t_{rr}$ | Reverse Recovery Time | $I_F$ = 19 A, di/dt = 300 A/μs | | 29 | 47 | ns |
| $Q_{rr}$ | Reverse Recovery Charge | | | 33 | 53 | nC |

Notes:
1. $R_{\theta JA}$ is determined with the device mounted on a 1 $in^2$ pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 $in^2$ pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.
3. $E_{AS}$ of 66 mJ is based on starting $T_J$ = 25 °C, L = 0.3 mH, $I_{AS}$ = 21 A, $V_{DD}$ = 27 V, $V_{GS}$ = 10 V. 100% tested at L= 3 mH, $I_{AS}$ = 10.2 A.
4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

## Typical Characteristics $T_J$ = 25 °C unless otherwise noted

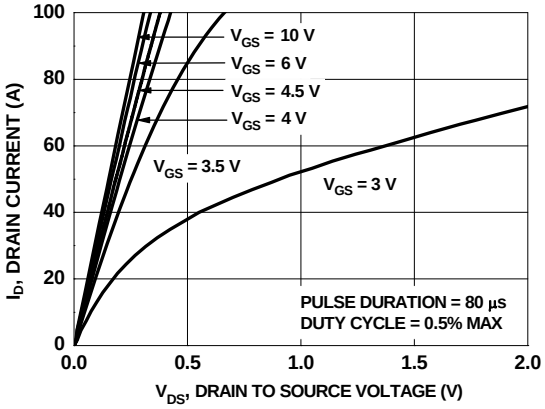



**Figure 1. On Region Characteristics**

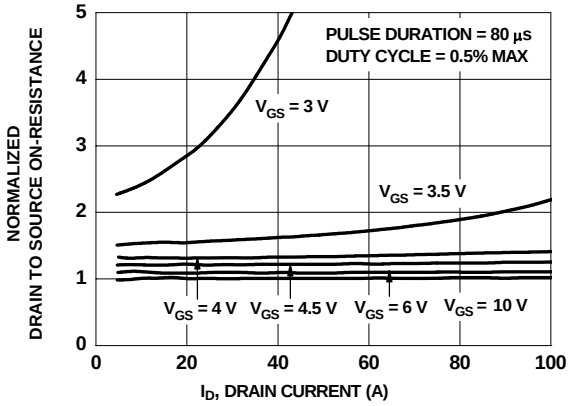



**Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage**

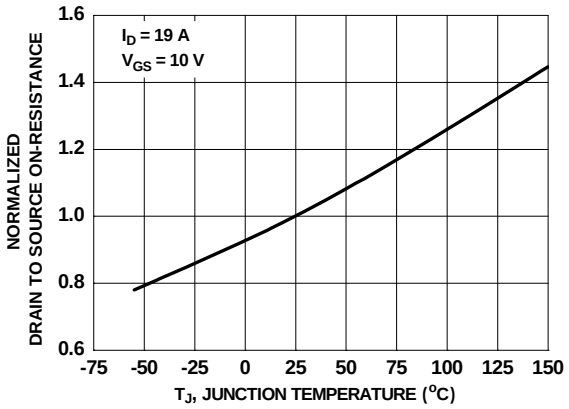



**Figure 3. Normalized On Resistance vs. Junction Temperature**

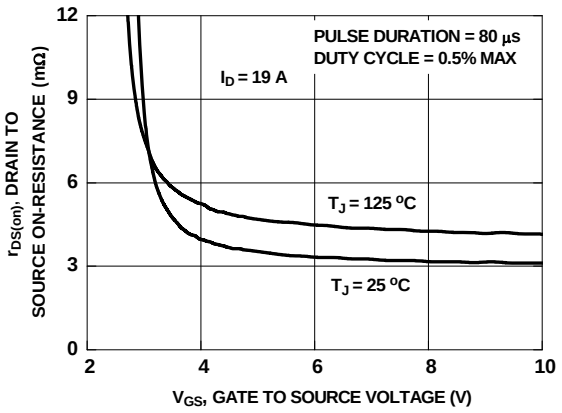



**Figure 4. On-Resistance vs. Gate to Source Voltage**

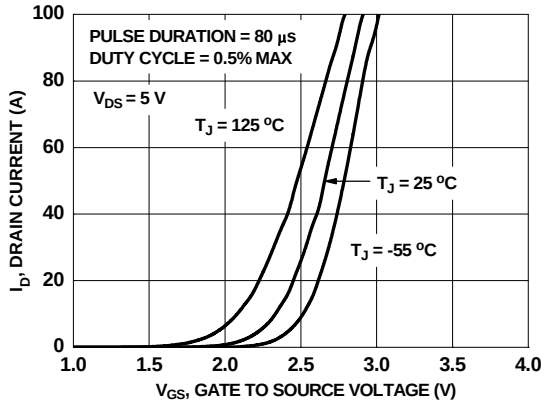



**Figure 5. Transfer Characteristics**

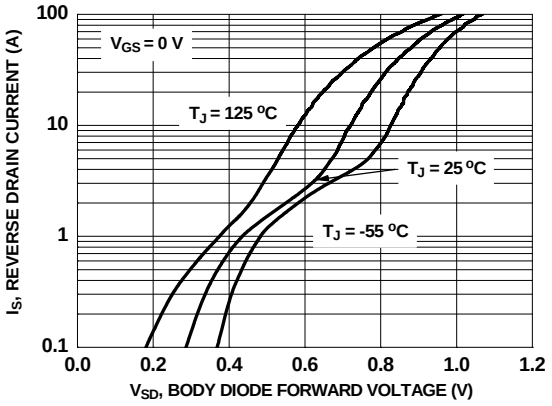



**Figure 6. Source to Drain Diode Forward Voltage vs. Source Current**

## Typical Characteristics $T_J$ = 25 °C unless otherwise noted

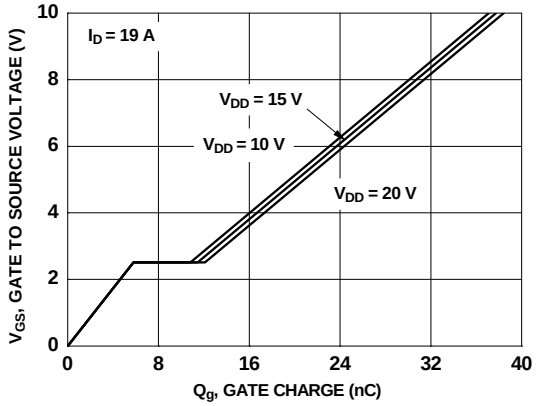



**Figure 7. Gate Charge Characteristics**

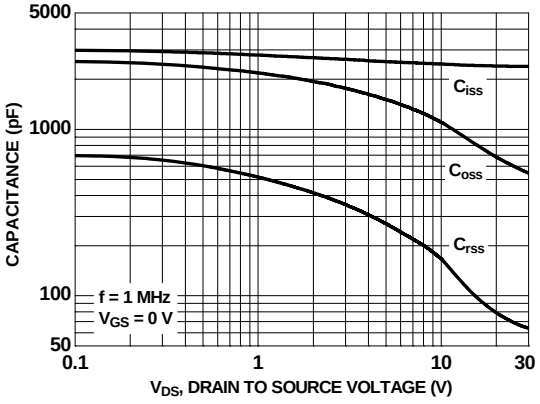



**Figure 8. Capacitance vs. Drain to Source Voltage**

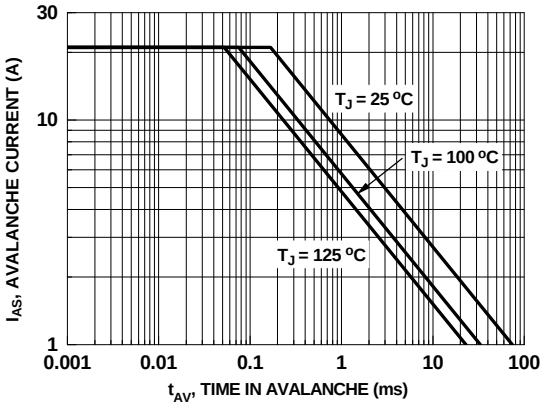



**Figure 9. Unclamped Inductive Switching Capability**

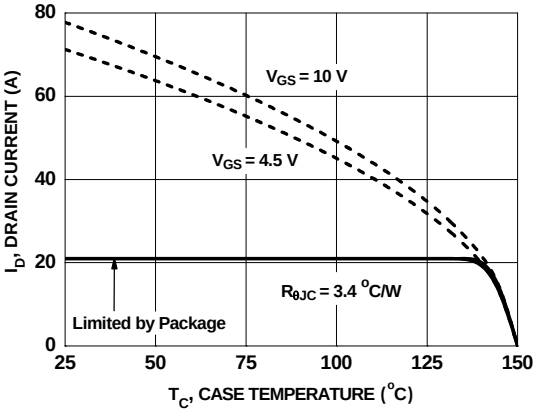



**Figure 10. Maximum Continuous Drain Current vs. Case Temperature**

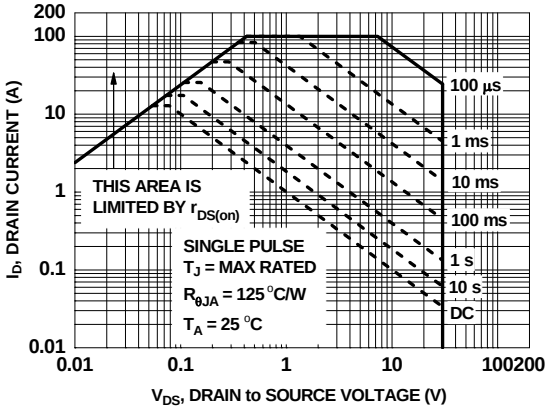



**Figure 11. Forward Bias Safe Operating Area**

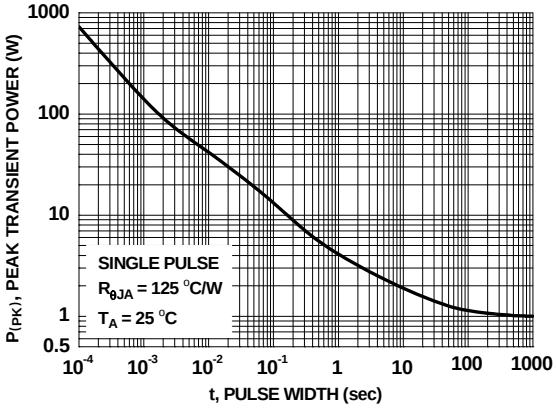



**Figure 12. Single Pulse Maximum Power Dissipation**

## Typical Characteristics $T_J$ = 25 °C unless otherwise noted

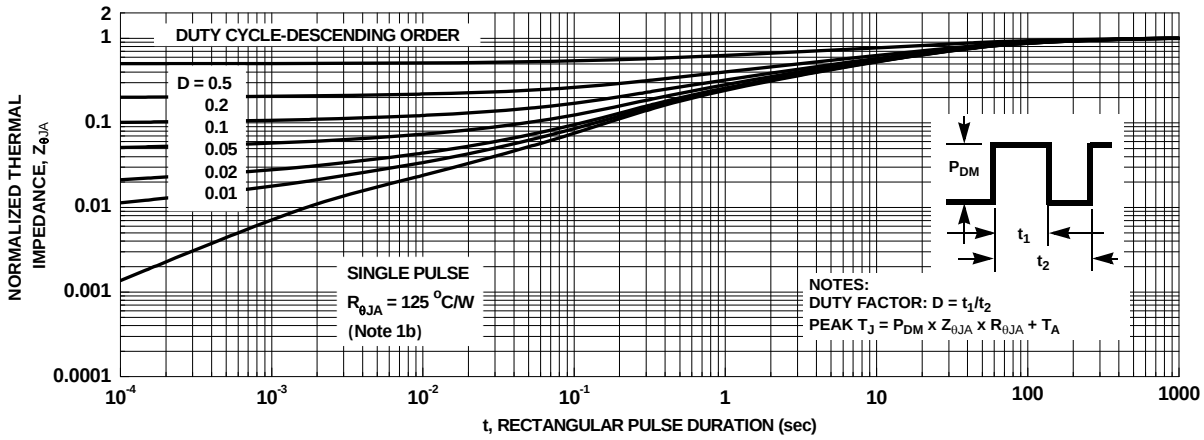



**Figure 13. Junction-to-Ambient Transient Thermal Response Curve**

## Typical Characteristics (continued)

### SyncFET™ Schottky body diode Characteristics

ON Semiconductor SyncFET™ process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMC0310AS.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

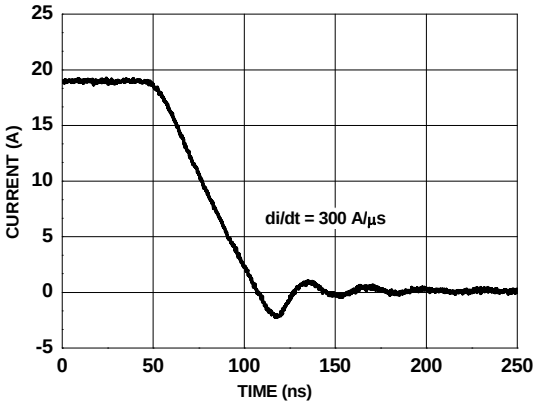



**Figure 14. SyncFET™ Body Diode Reverse Recovery Characteristic**

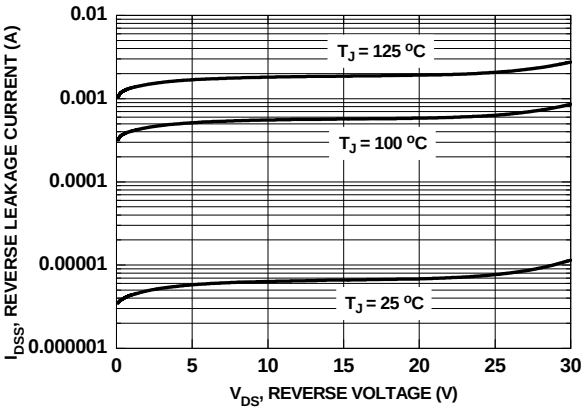



**Figure 15. SyncFET™ Body Diode Reverse Leakage vs. Drain-Source Voltage**

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